Notice of References Cited Application/Control No. 10/562,928 Examiner Tan Ho Applicant(s)/Patent Under Reexamination HARADA ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,451,965 A	09-1995	Matsumoto, Wataru	343/702
*	В	US-6,011,519 A	01-2000	Sadler et al.	343/742
*	C	US-6,442,399 B1	08-2002	Tsuru et al.	455/575.7
*	D	US-7,050,007 B2	05-2006	Akiho et al.	343/702
*	E	US-2004/0198428 A1	10-2004	Hong et al.	455/556.1
*	F	US-2004/0095283 A1	05-2004	Park et al.	343/702
*	G	US-2002/0190906 A1	12-2002	Kim et al.	343/702
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	1 .	US-			
	J	US-			
	К	US-			
	٦	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.